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# Power Field Effect Transistor DPAK for Surface Mount

# N–Channel Enhancement–Mode Silicon Gate

This TMOS Power FET is designed for high speed, low loss power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds
- Low  $R_{DS(on)} 0.3 \Omega$  Max
- Rugged SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads
- Low Drive Requirement  $V_{GS(th)} = 4.0$  V Max
- Surface Mount Package on 16 mm Tape

### MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	150	Vdc
Drain–Gate Voltage ( $R_{GS}$ = 1.0 M $\Omega$ )	V <sub>DGR</sub>	150	Vdc
Gate–Source Voltage — Continuous	V <sub>GS</sub>	$\begin{array}{c}\pm\ 20\\\pm\ 40\end{array}$	Vdc
— Non–Repetitive $(t_p \le 50 \ \mu s)$	V <sub>GSM</sub>		Vpk
Drain Current — Continuous	I <sub>D</sub>	6.0	Adc
— Pulsed	I <sub>DM</sub>	20	
Total Power Dissipation @ T <sub>C</sub> = 25°C	PD	20	Watts
Derate above 25°C		0.16	W/°C
Total Power Dissipation @ $T_A = 25^{\circ}C$	P <sub>D</sub>	1.25	Watts
Derate above 25°C (Note 1)		0.01	W/°C
Total Power Dissipation @ $T_A = 25^{\circ}C$ (1)	P <sub>D</sub>	1.75	Watts
Derate above 25°C (Note 2)		0.014	W/°C
Operating and Storage Junction Temper- ature Range	T <sub>J</sub> , T <sub>stg</sub>	−65 to +150	°C

### THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Thermal Resistance – Junction to Case – Junction to Ambient (Note 1) – Junction to Ambient (Note 2)	R <sub>θJC</sub> R <sub>θJA</sub> R <sub>θJA</sub>	6.25 100 71.4	°C/W

1. When surface mounted to an FR4 board using the minimum recommended pad size.

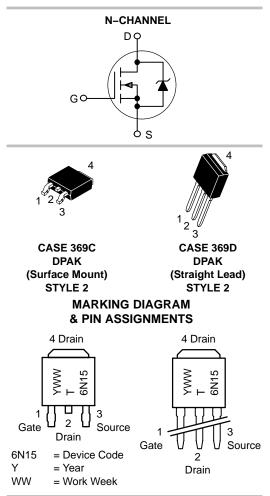
2. When surface mounted to an FR4 board using 0.5 sq. in. drain pad size.



# ON Semiconductor®

### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
150 V	0.3 Ω	6.0 A



### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
MTD6N15	DPAK	75 Units/Rail
MTD6N15-1	DPAK Straight Lead	75 Units/Rail
MTD6N15T4	DPAK	2500 Tape & Reel

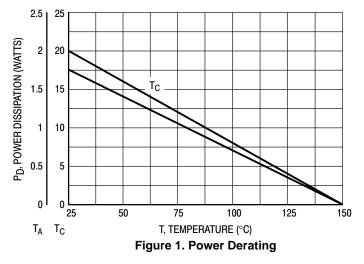
<sup>+</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Ch	Symbol	Min	Max	Unit	
OFF CHARACTERISTICS					
Drain–Source Breakdown Voltage $(V_{GS} = 0 \text{ Vdc}, I_D = 0.25 \text{ mAdc})$		V <sub>(BR)DSS</sub>	150	—	Vdc
Zero Gate Voltage Drain Current ( $V_{DS}$ = Rated $V_{DSS}$ , $V_{GS}$ = 0 Vdc) $T_J$ = 125°C		I <sub>DSS</sub>		10 100	μAdc
Gate-Body Leakage Current, Forwar	d (V <sub>GSF</sub> = 20 Vdc, V <sub>DS</sub> = 0)	I <sub>GSSF</sub>	—	100	nAdc
Gate-Body Leakage Current, Revers	$e (V_{GSR} = 20 \text{ Vdc}, V_{DS} = 0)$	I <sub>GSSR</sub>	—	100	nAdc
ON CHARACTERISTICS (Note 3)					
Gate Threshold Voltage (V <sub>DS</sub> = V <sub>GS</sub> , T <sub>J</sub> = 100°C	I <sub>D</sub> = 1.0 mAdc)	V <sub>GS(th)</sub>	2.0 1.5	4.5 4.0	Vdc
Static Drain–Source On–Resistance	(V <sub>GS</sub> = 10 Vdc, I <sub>D</sub> = 3.0 Adc)	R <sub>DS(on)</sub>	—	0.3	Ohm
$\label{eq:constraint} \begin{split} & \text{Drain-Source On-Voltage (V_{GS} = 10)} \\ & (\text{I}_{D} = 6.0 \text{ Adc}) \\ & (\text{I}_{D} = 3.0 \text{ Adc}, \text{ T}_{J} = 100^{\circ}\text{C}) \end{split}$	V <sub>DS(on)</sub>		1.8 1.5	Vdc	
Forward Transconductance ( $V_{DS} = 1$	9fs	2.5	_	mhos	
YNAMIC CHARACTERISTICS					
Input Capacitance	(V <sub>DS</sub> = 25 Vdc, V <sub>GS</sub> = 0 Vdc,	C <sub>iss</sub>	—	1200	pF
Output Capacitance	f = 1.0 MHz)	C <sub>oss</sub>	—	500	
Reverse Transfer Capacitance	See Figure 11	C <sub>rss</sub>	—	120	
WITCHING CHARACTERISTICS* (T	<sub>J</sub> = 100°C)				
Turn-On Delay Time		t <sub>d(on)</sub>	—	50	ns
Rise Time	$(V_{DD} = 25 \text{ Vdc}, I_D = 3.0 \text{ Adc}, R_G = 50 \Omega)$	tr	—	180	
Turn–Off Delay Time	$R_G = 50.02)$ See Figures 13 and 14	t <sub>d(off)</sub>	—	200	
Fall Time		t <sub>f</sub>	—	100	
Total Gate Charge	$(V_{DS} = 0.8 \text{ Rated } V_{DSS},$	Qg	15 (Typ)	30	nC
Gate-Source Charge	$I_D$ = Rated $I_D$ , $V_{GS}$ = 10 Vdc)	Q <sub>gs</sub>	8.0 (Typ)	—	1
Gate-Drain Charge See Figure 12		Q <sub>gd</sub>	7.0 (Typ)	_	
OURCE-DRAIN DIODE CHARACTE	RISTICS*				
Forward On–Voltage		V <sub>SD</sub>	1.3 (Typ)	2.0	Vdc
Forward Turn-On Time	$(I_{S} = 6.0 \text{ Adc}, \text{ di/dt} = 25 \text{ A/}\mu\text{s})$	t <sub>on</sub>	Limited by stray inducta		uctance

Forward Turn-On Time $t_{on}$ LimitedReverse Recovery Time $t_{rr}$ 325 (Typ)

3. Pulse Test: Pulse Width  $\leq$  300  $\mu s,$  Duty Cycle  $\leq$  2%.



ns

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#### 24 VGS(th), GATE THRESHOLD VOLTAGE (VOLTS) 3.6 10 V 9 V 20 $V_{DS} = V_{GS}$ I<sub>D</sub>, DRAIN CURRENT (AMPS) 3.2 T<sub>J</sub> = 25°C $I_D = 1 \text{ mA}$ 16 8 V 2.8 12 2.4 7 V 8 2 6 V 4 5 V $\widetilde{\tau}$ 0 60 - 50 0 10 20 30 40 50 0 50 100 150 V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (VOLTS) TJ, JUNCTION TEMPERATURE (°C) Figure 2. On-Region Characteristics Figure 3. Gate-Threshold Voltage Variation With Temperature V(BR)DSS, DRAIN-TO-SOURCE BREAKDOWN VOLTAGE (NORMALIZED) 14 2 V<sub>DS</sub> = 10 V T.I = 25°C V<sub>GS</sub> = 0 V 12 I<sub>D</sub> = 0.25 mA I<sub>D</sub> , DRAIN CURRENT (AMPS) 1.6 10 1.2 8 6 0.8 4 100°C - 55°C 0.4 2 0 L 0 10 8 - 50 50 100 150 6 0 200 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS) TJ, JUNCTION TEMPERATURE (°C) **Figure 4. Transfer Characteristics** Figure 5. Breakdown Voltage Variation With Temperature RDS(on) , DRAIN-TO-SOURCE RESISTANCE (OHMS) 0.30 2 RDS(on) , DRAIN-TO-SOURCE RESISTANCE (NORMALIZED) V<sub>GS</sub> = 10 V V<sub>GS</sub> = 10 V T<sub>J</sub> = 100°C 0.25 I<sub>D</sub> = 3 A 1.6 0.20 25°C 1.2 0.15 0.8 - 55°C 0.10 0.4 0.05 0 0 - 50 12 20 0 50 100 150 0 4 8 16 200 TJ, JUNCTION TEMPERATURE (°C) ID, DRAIN CURRENT (AMPS)



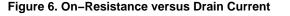


Figure 7. On–Resistance Variation With Temperature

# SAFE OPERATING AREA

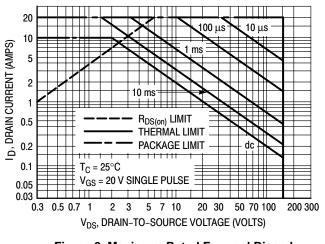


Figure 8. Maximum Rated Forward Biased Safe Operating Area

The FBSOA curves define the maximum drain-to-source

voltage and drain current that a device can safely handle

when it is forward biased, or when it is on, or being turned

on. Because these curves include the limitations of

simultaneous high voltage and high current, up to the rating

of the device, they are especially useful to designers of linear

systems. The curves are based on a case temperature of 25°C

and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola

AN569,

Resistance-General Data and Its Use" provides detailed

"Transient

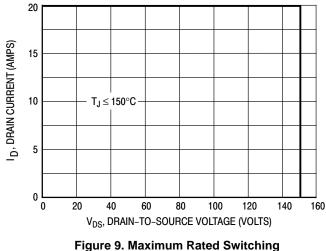
Thermal

FORWARD BIASED SAFE OPERATING AREA

Application

instructions.

Note,



Safe Operating Area

### SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 9 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current,  $I_{DM}$  and the breakdown voltage,  $V_{(BR)DSS}$ . The switching SOA shown in Figure 8 is applicable for both turn–on and turn–off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$\frac{\mathsf{T}_{\mathsf{J}(\mathsf{max})} - \mathsf{T}_{\mathsf{C}}}{\mathsf{R}_{\mathsf{\theta}\mathsf{J}\mathsf{C}}}$$

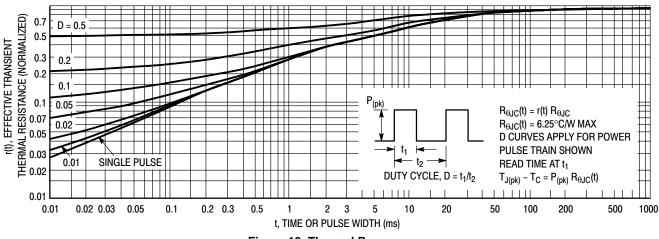


Figure 10. Thermal Response

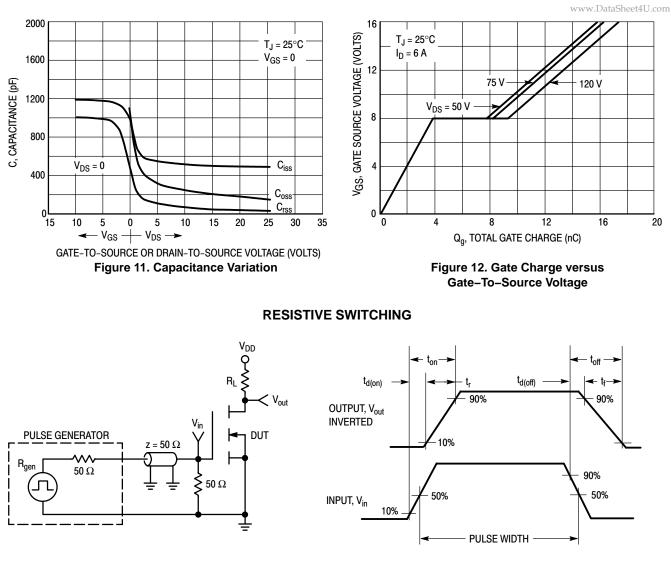
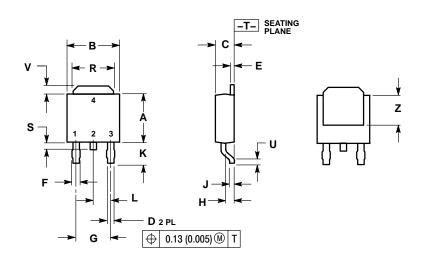


Figure 13. Switching Test Circuit

Figure 14. Switching Waveforms

## PACKAGE DIMENSIONS

DPAK CASE 369C-01 ISSUE O



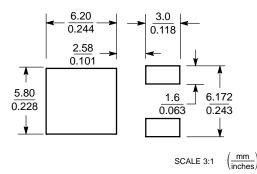
NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROL LING DIMENSION: INCH.

2. C	ONTROL	LING DIN	IENSION:	INCH

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
в	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180 BSC		4.58 BSC	
н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
ĸ	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
۷	0.035	0.050	0.89	1.27
Z	0.155		3.93	

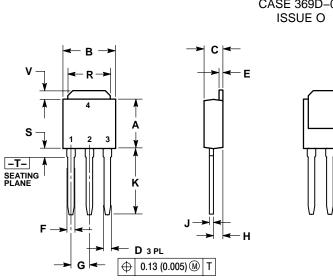
STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# PACKAGE DIMENSIONS



DPAK CASE 369D-01

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	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
в	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29 BSC	
н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
κ	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Ζ	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

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